# **3.3 V Differential 1:10** Fanout Clock Driver with HCSL Outputs

# NB3N111K

#### Description

The NB3N111K is a differential 1:10 Clock fanout buffer with High-speed Current Steering Logic (HCSL) outputs optimized for ultra low propagation delay variation. The NB3N111K is designed with PCI Express HCSL clock distribution and FBDIMM applications in mind.

Inputs can directly accept differential LVPECL, LVDS, and HCSL signals per Figures 7, 8, and 9. Single–ended LVPECL, HCSL, LVCMOS, or LVTTL levels are accepted with a proper external  $V_{th}$  reference supply per Figures 4 and 10. Input pins incorporate separate internal 50  $\Omega$  termination resistors allowing additional single ended system interconnect flexibility.

Output drive current is set by connecting a 475  $\Omega$  resistor from IREF (Pin 1) to GND per Figure 6. Outputs can also interface to LVDS receivers when terminated per Figure 11.

The NB3N111K specifically guarantees low output-to-output skew. Optimal design, layout, and processing minimize skew within a device and from device to device. System designers can take advantage of the NB3N111K's performance to distribute low skew clocks across the backplane or the motherboard.

#### Features

- Typical Input Clock Frequency 100, 133, 166, or 400 MHz
- 220 ps Typical Rise and Fall Times
- 800 ps Typical Propagation Delay
- Δtpd 100 ps Maximum Propagation Delay Variation per Diff Pair
- 0.1 ps Typical RMS Additive Phase Jitter
- LVDS Output Levels Optional with Interface Termination
- Operating Range:  $V_{CC} = 3.0 \text{ V}$  to 3.6 V with GND = 0 V
- Typical HCSL Output Levels (700 mV Peak-to-Peak)
- LVDS Output Levels with Interface Termination
- These are Pb-Free Devices

#### Applications

- Clock Distribution
- PCIe I, II, III
- Networking
- High End Computing
- Routers

#### End Products

- Servers
- FBDIMM Memory Card



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MN SUFFIX CASE 488AM

#### **MARKING DIAGRAM\***







Figure 1. Simplified Logic Diagram

#### **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 8 of this data sheet.



Figure 2. Pinout Configuration (Top View)

#### Table 1. PIN DESCRIPTION

Pin	Name	I/O	Description
1	IREF		Use the IREF pin to set the output drive. Connect a 475 $\Omega$ RREF resistor from the IREF pin to GND to produce 2.6 mA of IREF current. A current mirror multiplies IREF by a factor of 5.4x to force 14 mA through a 50 $\Omega$ output load. See Figures 6 and 12.
2, 5	VTCLK, VTCLK	-	Internal 50 $\Omega$ Termination Resistor connection Pins. In the differential configuration when the input termination pins are connected to the common termination voltage, and if no signal is applied then the device may be susceptible to self–oscillation.
3	CLK	LVPECL, HCSL, LVDS Input	Clock and Data (TRUE) Input
4	CLK	LVPECL, HCSL, LVDS Input	Clock and Data (INVERT) Input
6, 10, 12, 14, 18, 20, 22, 26, 28, 30	Q[9-0]	HCSL or LVDS (Note 1) Output	Output (INVERT) (Note 1)
7, 11, 13, 15, 19, 21, 23, 27, 29, 31	Q[9–0]	HCSL or LVDS (Note 1) Output	Output (TRUE) (Note 1)
8	GND	-	Supply Ground. GND pin must be externally connected to power supply to guarantee proper operation.
9, 16, 17, 24, 25, 32	VCC	-	Positive Voltage Supply pin. VCC pins must be externally connected to a power supply to guarantee proper operation.
Exposed Pad	EP	GND	Exposed Pad. The thermally exposed pad (EP) on package bottom (see case drawing) must be attached to a sufficient heat-sinking conduit for proper thermal operation and electrically connected to the circuit board ground (GND).

1. Outputs can also interface to LVDS receiver when terminated per Figure 11.

#### **Table 2. ATTRIBUTES**

Characteristic	Value			
ESD Protection Human Body Model Machine Model	>2 kV 200 V			
Moisture Sensitivity (Note 2) QFN32	Level 1			
Flammability Rating Oxygen Index: 28 to 34	UL 94 V-0 @ 0.125 in			
Transistor Count	286			
Meets or exceeds JEDEC Spec EIA/JESD78 IC Latchup Test				

2. For additional information, see Application Note AND8003/D.

#### Table 3. MAXIMUM RATINGS (Note 3)

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
$V_{CC}$	Positive Power Supply	GND = 0 V		4.6	V
VI	Positive Input	GND = 0 V		$GND-0.3 \leq V_{I} \leq V_{CC}$	V
VINPP	Differential Input Voltage			V <sub>CC</sub>	V
I <sub>OUT</sub>	Output Current	Continuous Surge		50 100	mA mA
T <sub>A</sub>	Operating Temperature Range	QFN32		-40 to +85	°C
T <sub>stg</sub>	Storage Temperature Range			–65 to +150	°C
$\theta_{JA}$	Thermal Resistance (Junction-to-Ambient) (Note 3)	0 lfpm 500 lfpm	QFN32 QFN32	31 27	°C/W °C/W
$\theta_{JC}$	Thermal Resistance (Junction-to-Case)	2S2P (Note 3)	QFN32	12	°C/W
T <sub>sol</sub>	Wave Solder Pb-Free			265	°C

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected. 3. JEDEC standard 51–6, multilayer board – 2S2P (2 signal, 2 power) with 8 filled thermal vias under exposed pad.

#### Table 4. DC CHARACTERISTICS (V<sub>CC</sub> = 3.0 V to 3.6 V, $T_A = -40^{\circ}C$ to +85°C Note 4)

Symbol	Characteristic	Min	Тур	Max	Unit		
I <sub>GND</sub>	GND Supply Current (All Outputs Loaded)		60	90	mA		
I <sub>CC</sub>	Power Supply Current (All Outputs Loaded)		210	260	mA		
Ι <sub>ΙΗ</sub>	Input HIGH Current		2.0	150	μA		
IIL	Input LOW Current	-150	-2.0		μA		
R <sub>TIN</sub>	Internal Input Termination Resistor	45	50	55	Ω		
DIFFERE	DIFFERENTIAL INPUT DRIVEN SINGLE-ENDED						
		I					

V <sub>th</sub>	Input Threshold Reference Voltage Range (Note 5)	350	V <sub>CC</sub> – 1000	mV
$V_{\text{IH}}$	Single – Ended Input HIGH Voltage	V <sub>th</sub> + 150	V <sub>CC</sub>	mV
$V_{IL}$	Single – Ended Input LOW Voltage	GND	V <sub>th</sub> – 150	mV

#### DIFFERENTIAL INPUTS DRIVEN DIFFERENTIALLY (Figures 7, 8 and 9)

V <sub>IHD</sub>	Differential Input HIGH Voltage	425	V <sub>CC</sub> - 850	mV
V <sub>ILD</sub>	Differential Input LOW Voltage	GND	V <sub>CC</sub> – 1000	mV
V <sub>ID</sub>	Differential Input Voltage (V <sub>IHD</sub> - V <sub>ILD</sub> )	150	V <sub>CC</sub> - 850	mV
V <sub>CMR</sub>	Input Common Mode Range	350	V <sub>CC</sub> – 1000	mV

HCSL OUTPUTS (Figure 4)

V <sub>OH</sub>	Output HIGH Voltage	600	740	900	mV
V <sub>OL</sub>	Output LOW Voltage	-150	0	150	mV

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

4. Measurements taken with outputs loaded 50 Ω to GND. Connect a 475 Ω resistor from IREF (Pin 1) to GND. See Figure 6.

5. V<sub>th</sub> is applied to the complementary input when operating in single ended mode per Figure 4.

Symbol	Characteristic		Min	Тур	Max	Unit
V <sub>OUTPP</sub>	Output Voltage Amplitude (@ $V_{INPPmin}$ ) $f_{in} \leq 400 \text{ MHz}$			725	1000	mV
t <sub>PLH</sub> , t <sub>PHL</sub>	Propagation Delay (See Figure 3a) CLK	CLK to Qx/Qx	550	800	1100	ps
$\Delta t_{PLH}, \ \Delta t_{PHL}$	Propagation Delay Variation Per Each Diff Pair (Note 7) (See Figure 3a) CLK	CLK to Qx/Qx			100	ps
t <sub>SKEW</sub>	Duty Cycle Skew (Note 8) Within –Device Skew Device to Device Skew (Note 9)				20 100 150	ps
$t_{JIT}\theta$	Additive Integrated Phase Jitter at Fc = 100 MHz (Note 10)			0.1		ps
V <sub>INPP</sub>	Input Voltage Swing/Sensitivity (Differential Configuration)		0.150		V <sub>CC</sub> - 0.85	V
V <sub>CROSS</sub>	Absolute Crossing Magnitude Voltage (See Figure 3b)		250		550	mV
$\Delta V_{CROSS}$	Variation in Magnitude of V <sub>CROSS</sub> (See Figure 3b)				150	mV
t <sub>r</sub> , t <sub>f</sub>	Absolute Magnitude in Output Risetime and Falltime (from 175 mV to 525 mV (See Figure 3b)	/) Qx, <del>Qx</del>	150	220	400	ps
$\Delta tr$ , $\Delta tf$	Variation in Magnitude of Risetime and Falltime (Single-Ended) (See Figure	3b) Qx, Qx			125	ps

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm.

 Measured by forcing V<sub>INPP</sub> (MIN) from a 50% duty cycle. Measurement taken with all outputs loaded 50 Ω to GND. Connect a 475 Ω resistor from IREF (Pin 1) to GND. See Figure 6.

7. Measured from the input pair crosspoint to each single output pair crosspoint across temp and voltage ranges per Figure 3.

8. Duty cycle skew is measured between differential outputs using the deviations of the sum of T<sub>pw-</sub> and T<sub>pw+</sub>.

9. Skew is measured between outputs under identical transition conditions @ 50 MHz.

10. Phase noise integrated from 12 kHz to 20 MHz.



(c) VCROSS and  $\Delta$ VCROSS

Figure 3. AC Reference Measurement









**A**. Connect 475  $\Omega$  resistor R<sub>REF</sub> from IREF pin to GND.

**B**. R<sub>S1</sub>, R<sub>S2</sub>: 0  $\Omega$  for Test and Evaluation. Select to Minimizing Ringing.

**C**.  $C_{L1}$ ,  $C_{L2}$ : Receiver Input Simulation (for test only not added to application circuit) Load capacitance only.

D. DL1, DL2 Termination and Load Resistors Located at Receiver Inputs.

#### Figure 6. Typical Termination Configuration for Output Driver and Device Evaluation



\*RTIN, Internal Input Termination Resistor

#### Figure 7. LVPECL Interface



\*RTIN, Internal Input Termination Resistor

#### Figure 8. LVDS Interface





\*RTIN, Internal Input Termination Resistor



\*RTIN, Internal Input Termination Resistor

#### Figure 10. LVCMOS/LVTTL Interface



Figure 11. HCSL Interface Termination to LVDS



Figure 12. HCSL Simplified Output Structure

#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NB3N111KMNR4G	QFN32 (Pb-Free)	1000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.





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DESCRIPTION:

QFN32 5x5 0.5P

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